

N- and P-Channel 30 V (D-S) MOSFET

PRODUCT SUMMARY				
	V _{DS} (V)	R _{DS(on)} (Ω)	I _D (A) ^a	Q _g (Typ.)
N-Channel	30	0.015 at V _{GS} = 10 V	26	19
		0.018 at V _{GS} = 4.5 V	22	
P-Channel	- 30	0.030 at V _{GS} = - 10 V	- 20	15
		0.042 at V _{GS} = - 4.5 V	- 17	

FEATURES

- DT-Trench Power MOSFET
- 100 % R_G and UIS Tested

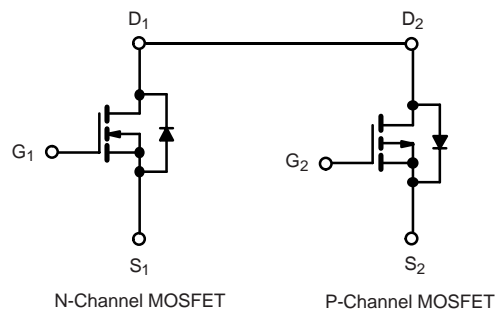
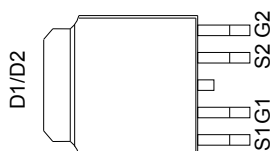
APPLICATIONS

- Inverter



RoHS
COMPLIANT

TO-252-4L



ABSOLUTE MAXIMUM RATINGS T_A = 25 °C, unless otherwise noted

Parameter	Symbol	N-Channel	P-Channel	Unit
Drain-Source Voltage	V _{DS}	30	- 30	V
Gate-Source Voltage	V _{GS}	± 20	± 20	
Continuous Drain Current (T _J = 150 °C)	I _D	T _C = 25 °C	26	A
		T _C = 70 °C	22	
		T _A = 25 °C	8.0 ^{b, c}	
		T _A = 70 °C	6.2 ^{b, c}	
Pulsed Drain Current (10 μs Pulse Width)	I _{DM}	78	-60	A
Source-Drain Current Diode Current	I _S	T _C = 25 °C	26	
		T _A = 25 °C	21 ^{b, c}	
Pulsed Source-Drain Current	I _{SM}	78	- 60	
Single Pulse Avalanche Current (T _J = 150 °C)	I _{AS}	10	- 20	mJ
Single Pulse Avalanche Energy (T _J = 150 °C)	E _{AS}	5	20	
Maximum Power Dissipation	P _D	T _C = 25 °C	31	W
		T _C = 70 °C	13	
		T _A = 25 °C	9 ^{b, c}	
		T _A = 70 °C	7.25 ^{b, c}	
Operating Junction and Storage Temperature Range	T _J , T _{stg}	- 55 to 150		°C

THERMAL RESISTANCE RATINGS

Parameter	Symbol	N-Channel		P-Channel		Unit
		Typ.	Max.	Typ.	Max.	
Maximum Junction-to-Ambient ^{b, d}	R _{thJA}	50	62	47	63	°C/W
Maximum Junction-to-Foot (Drain)	R _{thJF}	30	40	29	38	

Notes:

a. Based on T_C = 25 °C.

b. Surface Mounted on 1" x 1" FR4 board.

c. t = 10 s.

d. Maximum under Steady State conditions is 120 °C/W (N-Channel) and 110 °C/W (P-Channel).

SPECIFICATIONS $T_J = 25\text{ }^\circ\text{C}$, unless otherwise noted								
Parameter	Symbol	Test Conditions	Min.	Typ. ^a	Max.	Unit		
Static								
Drain-Source Breakdown Voltage	V_{DS}	$V_{GS} = 0\text{ V}, I_D = 250\text{ }\mu\text{A}$	N-Ch	30			V	
		$V_{GS} = 0\text{ V}, I_D = -250\text{ }\mu\text{A}$	P-Ch	-30				
V_{DS} Temperature Coefficient	$\Delta V_{DS}/T_J$	$I_D = 250\text{ }\mu\text{A}$	N-Ch		40		mV/ $^\circ\text{C}$	
		$I_D = -250\text{ }\mu\text{A}$	P-Ch		-40			
$V_{GS(th)}$ Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	$I_D = 250\text{ }\mu\text{A}$	N-Ch		-4.1			
		$I_D = -250\text{ }\mu\text{A}$	P-Ch		5.0			
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 250\text{ }\mu\text{A}$	N-Ch	0.5		2.5	V	
		$V_{DS} = V_{GS}, I_D = -250\text{ }\mu\text{A}$	P-Ch	-1.0		-3.0		
Gate-Body Leakage	I_{GSS}	$V_{DS} = 0\text{ V}, V_{GS} = \pm 20\text{ V}$	N-Ch			± 100	nA	
		$V_{DS} = 0\text{ V}, V_{GS} = \pm 20\text{ V}$	P-Ch			± 100		
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 24\text{ V}, V_{GS} = 0\text{ V}$	N-Ch			1	μA	
		$V_{DS} = -24\text{ V}, V_{GS} = 0\text{ V}$	P-Ch			-1		
		$V_{DS} = 24\text{ V}, V_{GS} = 0\text{ V}, T_J = 55\text{ }^\circ\text{C}$	N-Ch			10		
		$V_{DS} = -24\text{ V}, V_{GS} = 0\text{ V}, T_J = 55\text{ }^\circ\text{C}$	P-Ch			-10		
On-State Drain Current ^b	$I_{D(on)}$	$V_{DS} = 24\text{ V}, V_{GS} = 10\text{ V}$	N-Ch	26			A	
		$V_{DS} = -24\text{ V}, V_{GS} = -10\text{ V}$	P-Ch	-21				
Drain-Source On-State Resistance ^b	$R_{DS(on)}$	$V_{GS} = 10\text{ V}, I_D = 10\text{ A}$	N-Ch		0.015	0.018	Ω	
		$V_{GS} = -10\text{ V}, I_D = -8\text{ A}$	P-Ch		0.030	0.040		
		$V_{GS} = 4.5\text{ V}, I_D = 8\text{ A}$	N-Ch		0.018	0.022		
		$V_{GS} = -4.5\text{ V}, I_D = -6\text{ A}$	P-Ch		0.042	0.046		
Forward Transconductance ^b	g_{fs}	$V_{DS} = 24\text{ V}, I_D = 10\text{ A}$	N-Ch		25		S	
		$V_{DS} = -24\text{ V}, I_D = -10\text{ A}$	P-Ch		22			
Dynamic^a								
Input Capacitance	C_{iss}	N-Channel $V_{DS} = 24\text{ V}, V_{GS} = 0\text{ V}, f = 1\text{ MHz}$	N-Ch		1380		pF	
Output Capacitance	C_{oss}		P-Ch		506			
Reverse Transfer Capacitance	C_{rss}	P-Channel $V_{DS} = -24\text{ V}, V_{GS} = 0\text{ V}, f = 1\text{ MHz}$	N-Ch		150			
			P-Ch		960			
Total Gate Charge	Q_g	$V_{DS} = 24\text{ V}, V_{GS} = 10\text{ V}, I_D = 10\text{ A}$	N-Ch	17		30	nC	
		$V_{DS} = -24\text{ V}, V_{GS} = -10\text{ V}, I_D = -8\text{ A}$	P-Ch	35		50		
		N-Channel $V_{DS} = 24\text{ V}, V_{GS} = 4.5\text{ V}, I_D = 8\text{ A}$	N-Ch	20		30		
			P-Ch	15		27		
Gate-Source Charge	Q_{gs}	P-Channel $V_{DS} = -24\text{ V}, V_{GS} = -4.5\text{ V}, I_D = -6\text{ A}$	N-Ch	2.5				
Gate-Drain Charge	Q_{gd}		P-Ch	5.1				
Gate Resistance	R_g	$f = 1\text{ MHz}$	N-Ch	0.3	1.5	3.0		Ω
			P-Ch	1.3	6.4	12.8		

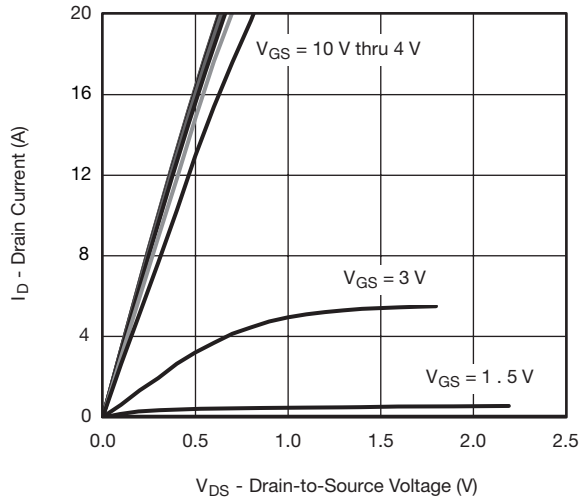
SPECIFICATIONS $T_J = 25\text{ }^\circ\text{C}$, unless otherwise noted							
Parameter	Symbol	Test Conditions		Min.	Typ. ^a	Max.	Unit
Dynamic^a							
Turn-On Delay Time	$t_{d(on)}$	N-Channel $V_{DD} = 24\text{ V}, R_L = 2\ \Omega$ $I_D \cong 10\text{ A}, V_{GEN} = 10\text{ V}, R_g = 1\ \Omega$	N-Ch		8	14	ns
Rise Time	t_r		P-Ch		10	18	
Turn-Off Delay Time	$t_{d(off)}$	P-Channel $V_{DD} = -24\text{ V}, R_L = 2\ \Omega$ $I_D \cong -8\text{ A}, V_{GEN} = -10\text{ V}, R_g = 1\ \Omega$	N-Ch		11	20	
			P-Ch		9	18	
Fall Time	t_f		N-Ch		18	36	
			P-Ch		50	90	
Turn-On Delay Time	$t_{d(on)}$	N-Channel $V_{DD} = 24\text{ V}, R_L = 2\ \Omega$ $I_D \cong 8\text{ A}, V_{GEN} = 4.5\text{ V}, R_g = 1\ \Omega$	N-Ch		9	18	
			P-Ch		14	28	
Rise Time	t_r		N-Ch		11	22	
			P-Ch		42	75	
Turn-Off Delay Time	$t_{d(off)}$	P-Channel $V_{DD} = -24\text{ V}, R_L = 2\ \Omega$ $I_D \cong -6\text{ A}, V_{GEN} = -4.5\text{ V}, R_g = 1\ \Omega$	N-Ch		15	30	
			P-Ch		40	70	
Fall Time	t_f		N-Ch		23	46	
			P-Ch		40	70	
			N-Ch		13	26	
			P-Ch		15	30	
Drain-Source Body Diode Characteristics							
Continuous Source-Drain Diode Current	I_S	$T_C = 25\text{ }^\circ\text{C}$	N-Ch			26	A
			P-Ch			-20	
Pulse Diode Forward Current ^a	I_{SM}		N-Ch			78	A
			P-Ch			-60	
Body Diode Voltage	V_{SD}	$I_S = 2\text{ A}$	N-Ch		0.75	1.2	V
		$I_S = -2\text{ A}$	P-Ch		-0.75	-1.2	
Body Diode Reverse Recovery Time	t_{rr}	N-Channel $I_F = 5\text{ A}, dI/dt = 100\text{ A}/\mu\text{s}, T_J = 25\text{ }^\circ\text{C}$	N-Ch		15	30	ns
			P-Ch		30	60	
Body Diode Reverse Recovery Charge	Q_{rr}		N-Ch		10	20	nC
			P-Ch		26	52	
Reverse Recovery Fall Time	t_a	P-Channel $I_F = -5\text{ A}, dI/dt = -100\text{ A}/\mu\text{s}, T_J = 25\text{ }^\circ\text{C}$	N-Ch		10		ns
			P-Ch		15		
Reverse Recovery Rise Time	t_b		N-Ch		7		
			P-Ch		15		

Notes:

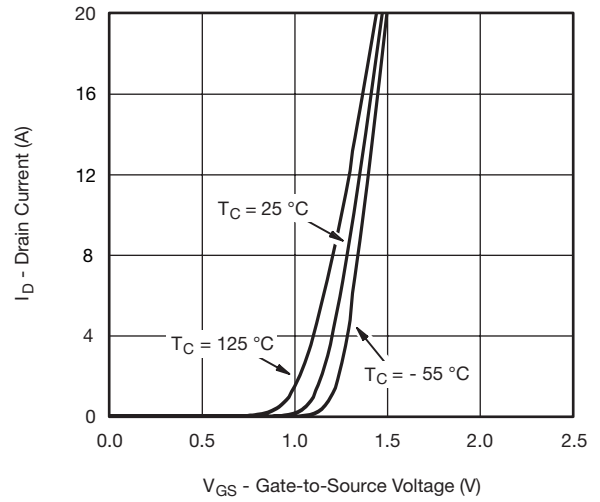
- a. Guaranteed by design, not subject to production testing.
- b. Pulse test; pulse width $\leq 300\ \mu\text{s}$, duty cycle $\leq 2\%$.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

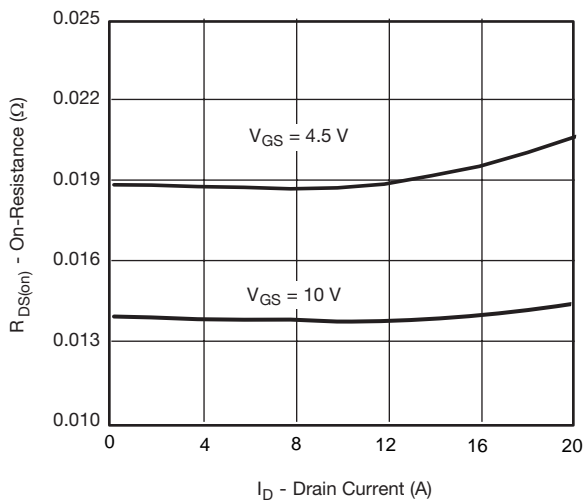
N-CHANNEL TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



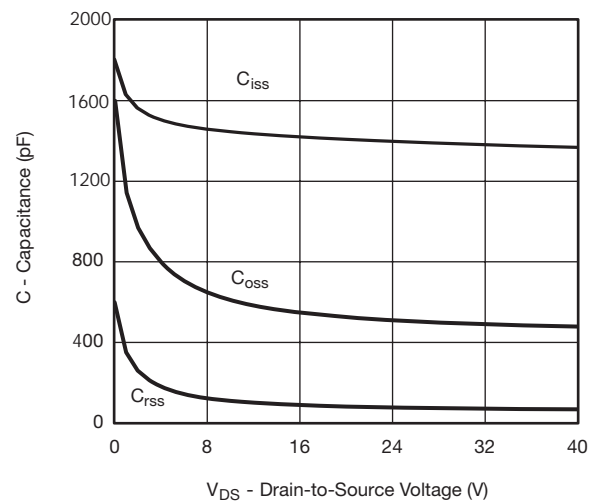
Output Characteristics



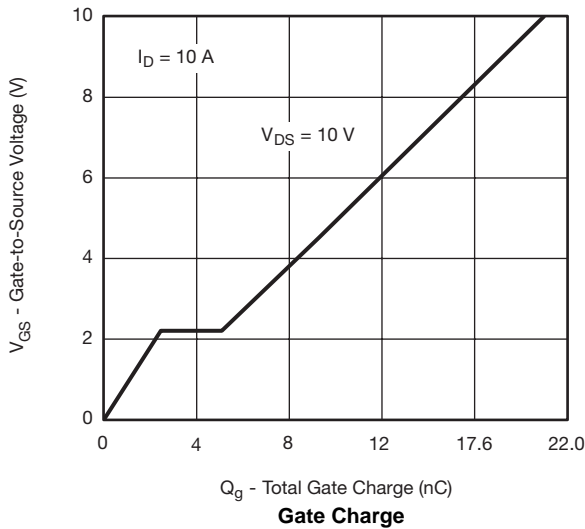
Transfer Characteristics



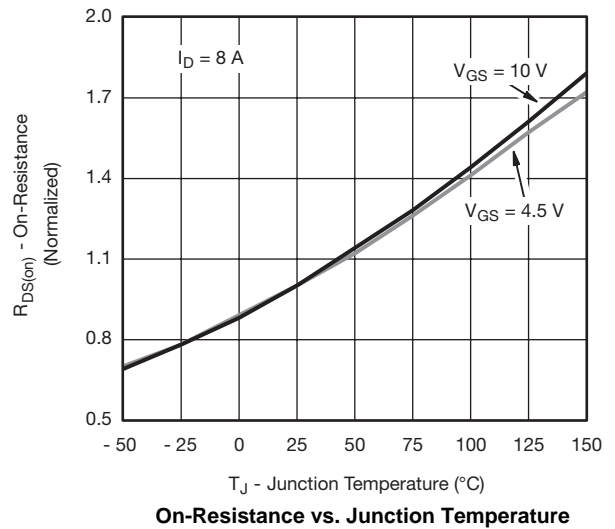
On-Resistance vs. Drain Current and Gate Voltage



Capacitance

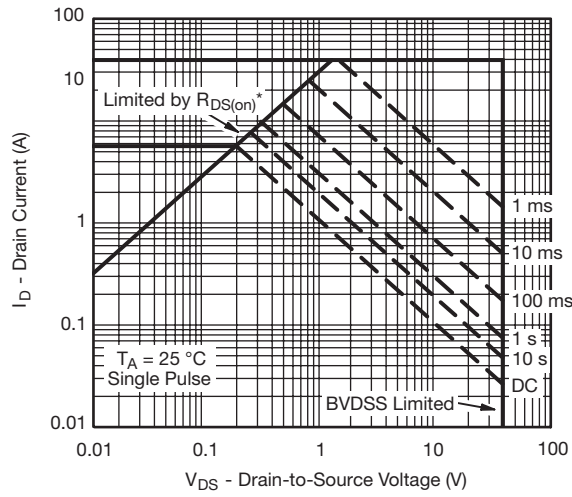
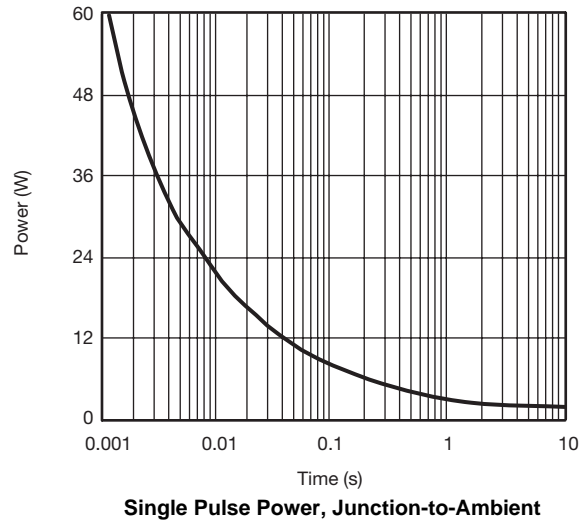
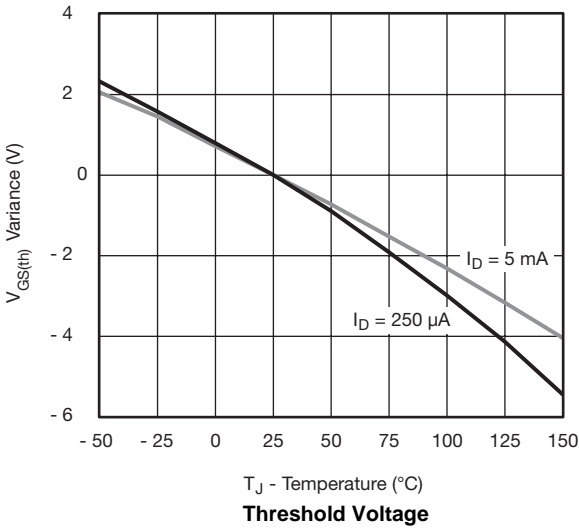
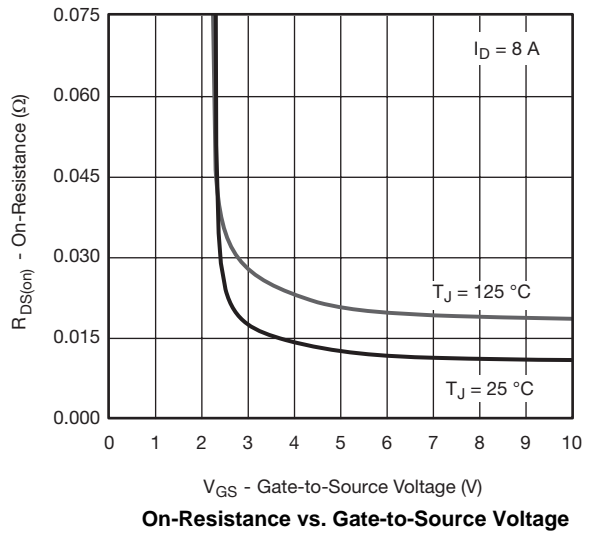
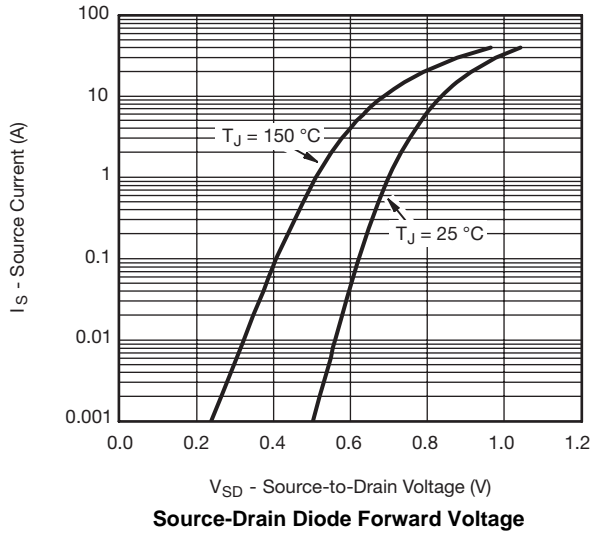


Gate Charge



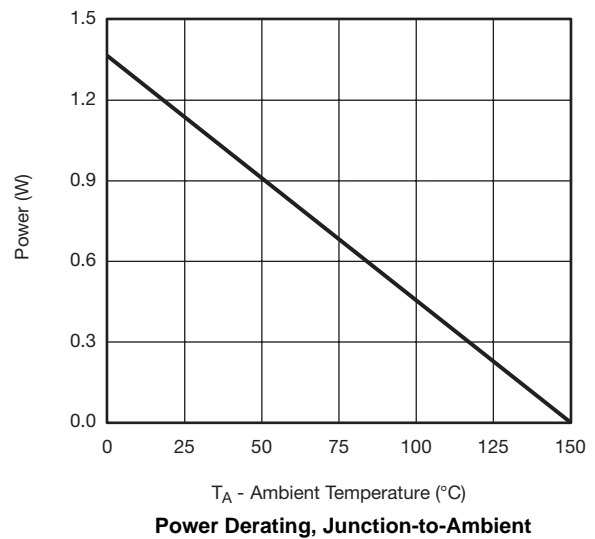
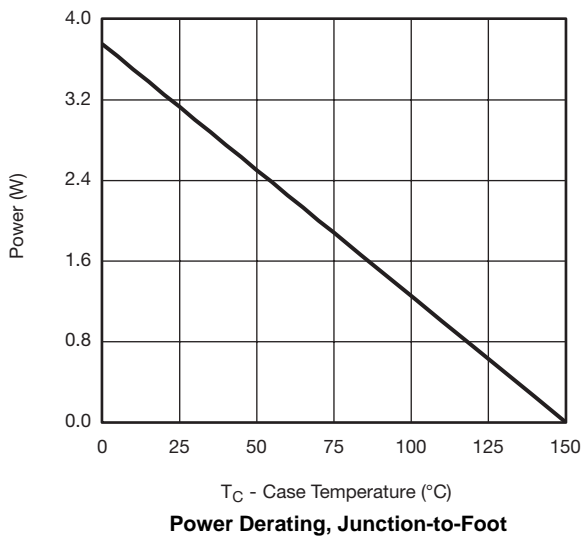
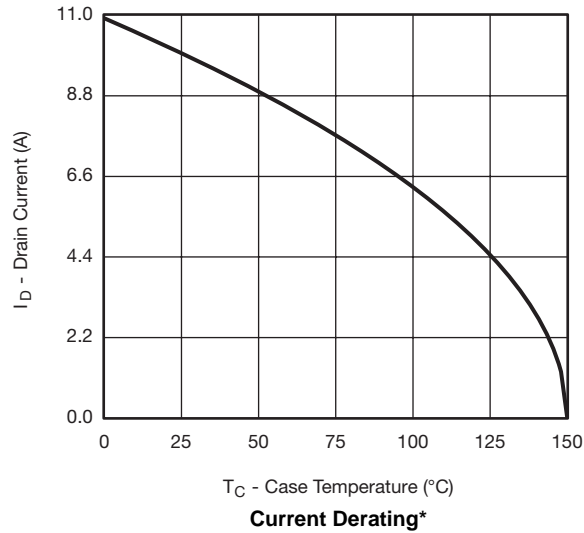
On-Resistance vs. Junction Temperature

N-CHANNEL TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



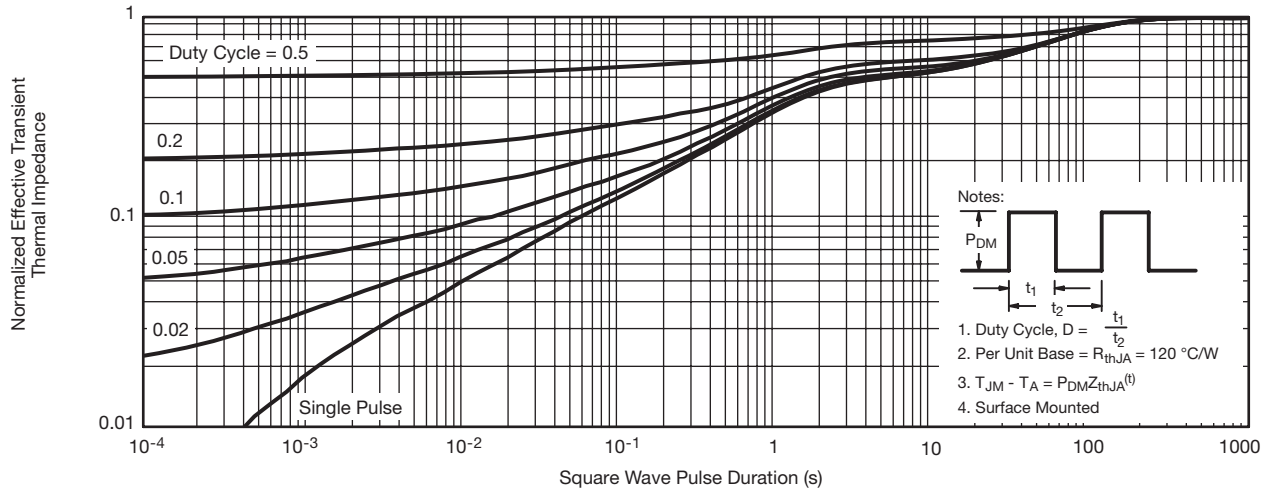
* $V_{GS} >$ minimum V_{GS} at which $R_{DS(on)}$ is specified
Safe Operating Area, Junction-to-Ambient

N-CHANNEL TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

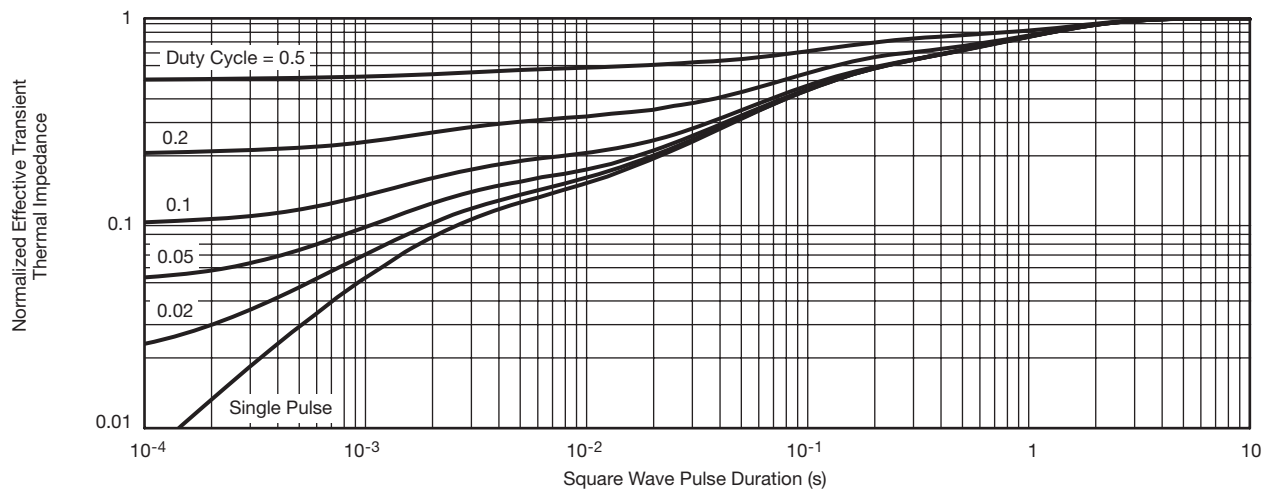


* The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

N-CHANNEL TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

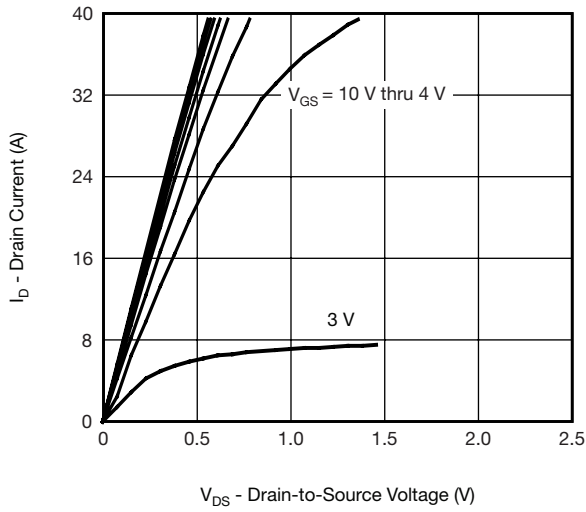


Normalized Thermal Transient Impedance, Junction-to-Ambient

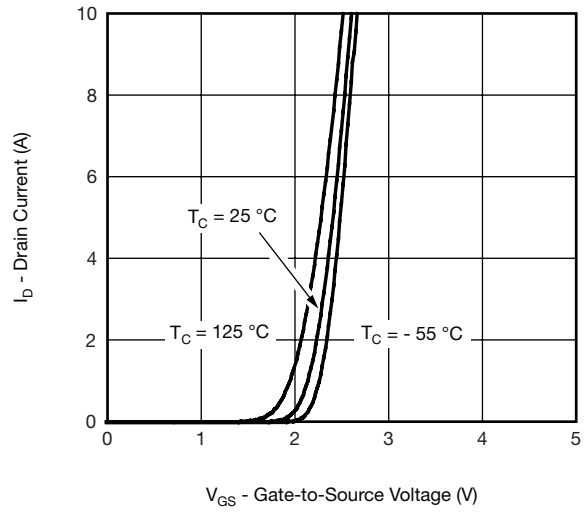


Normalized Thermal Transient Impedance, Junction-to-Foot

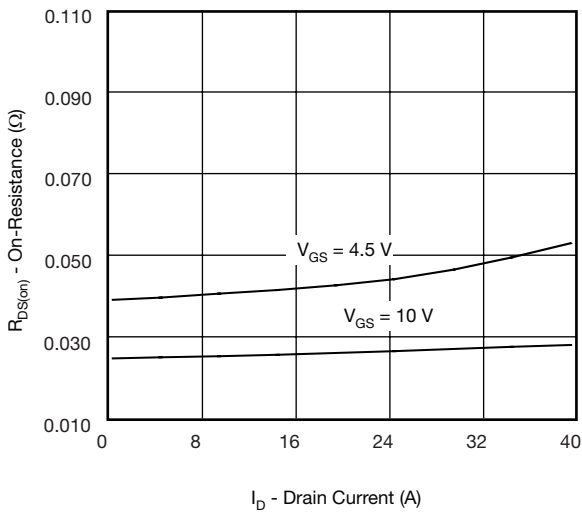
P-CHANNEL TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



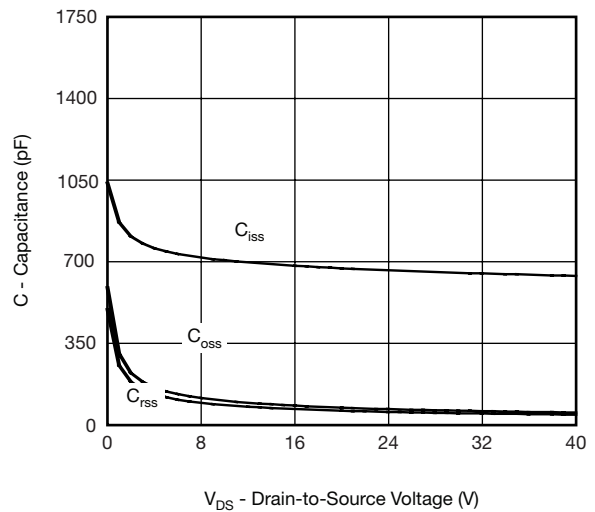
Output Characteristics



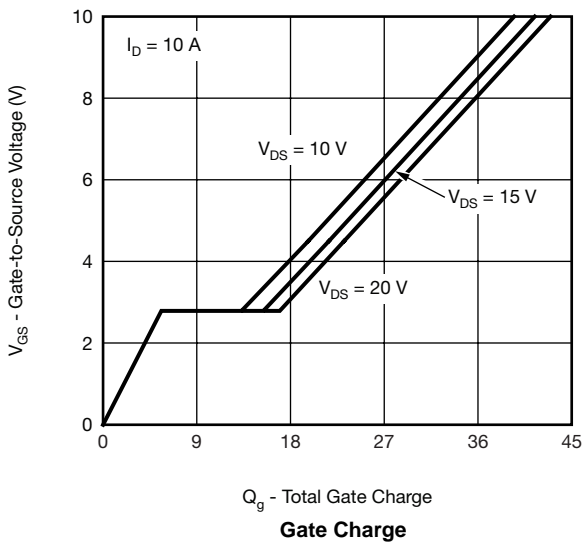
Transfer Characteristics



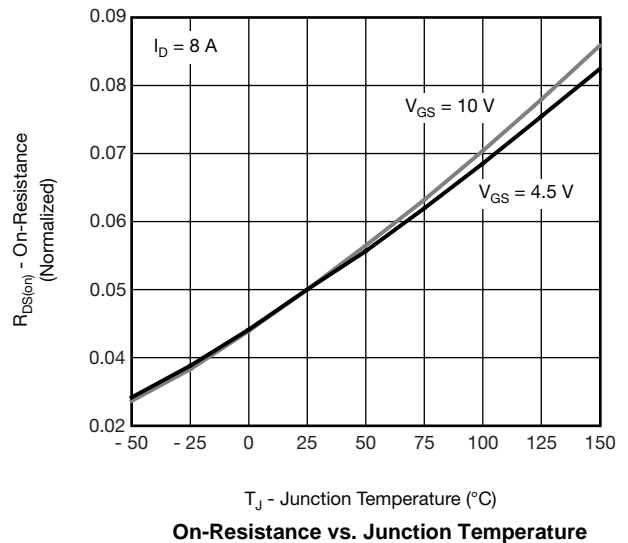
On-Resistance vs. Drain Current and Gate Voltage



Capacitance

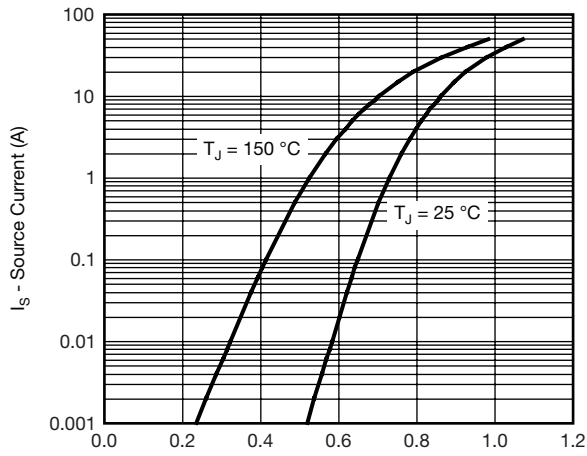


Gate Charge

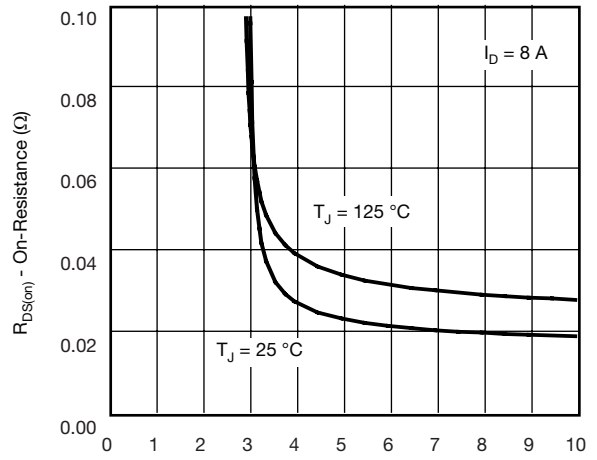


On-Resistance vs. Junction Temperature

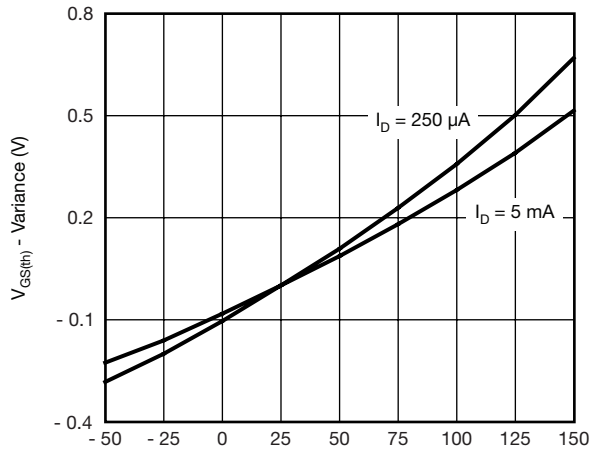
P-CHANNEL TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



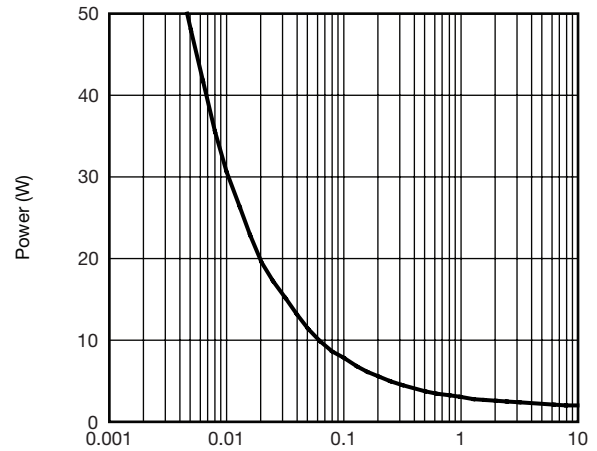
V_{SD} - Source-to-Drain Voltage (V)
Source-Drain Diode Forward Voltage



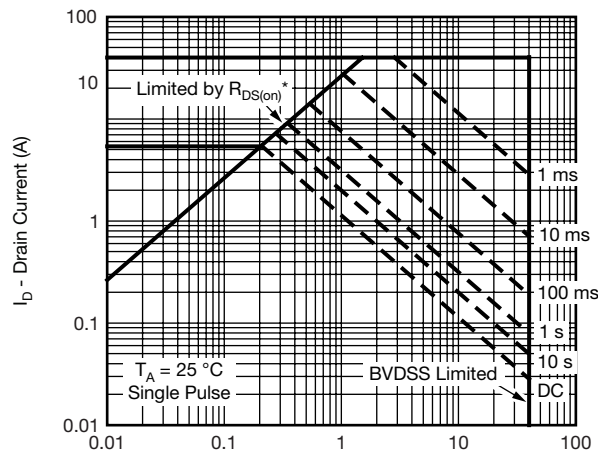
V_{GS} - Gate-to-Source Voltage (V)
On-Resistance vs. Gate-to-Source Voltage



T_J - Junction Temperature ($^\circ\text{C}$)
Threshold Voltage

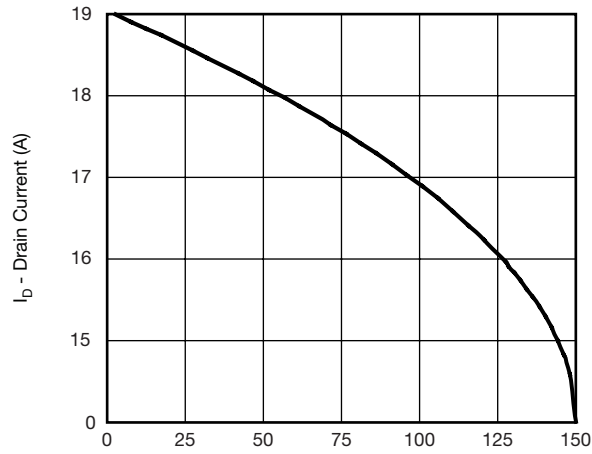


Single Pulse Power, Junction-to-Ambient



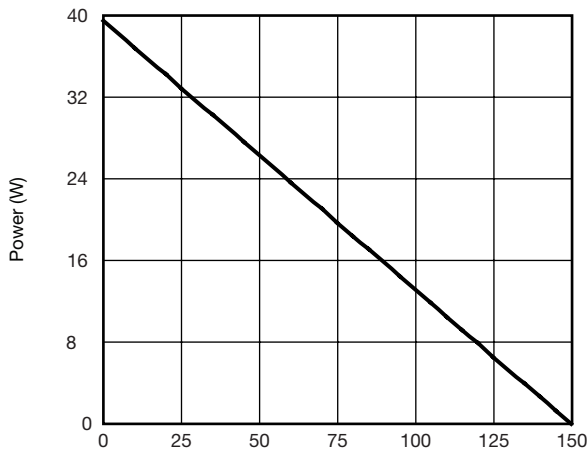
V_{DS} - Drain-to-Source Voltage (V)
* $V_{GS} >$ minimum V_{GS} at which $R_{DS(on)}$ is specified
Safe Operating Area, Junction-to-Ambient

P-CHANNEL TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



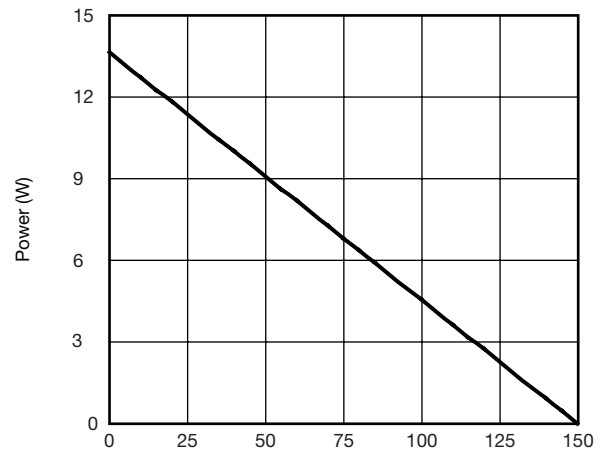
T_C - Case Temperature (°C)

Current Derating*



T_C - Case Temperature (°C)

Power Derating, Junction-to-Foot

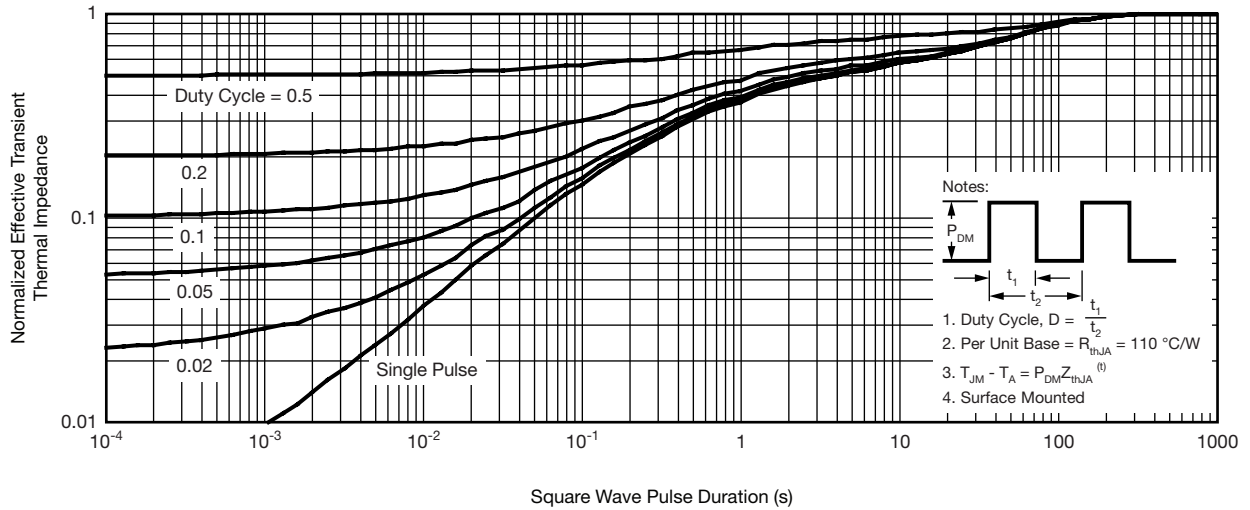


T_A - Ambient Temperature (°C)

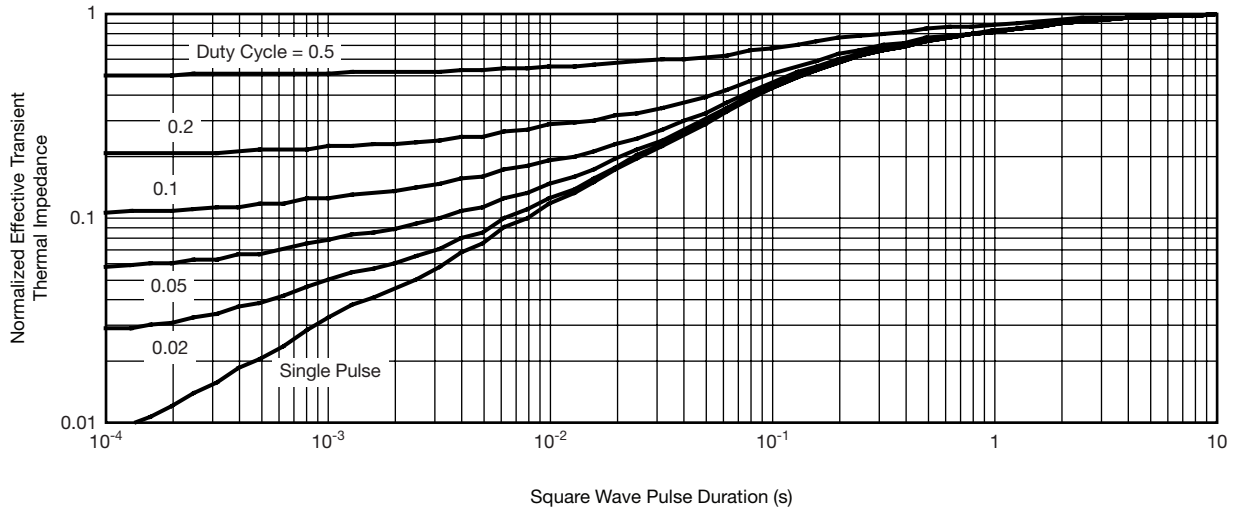
Power Derating, Junction-to-Ambient

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P-CHANNEL TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

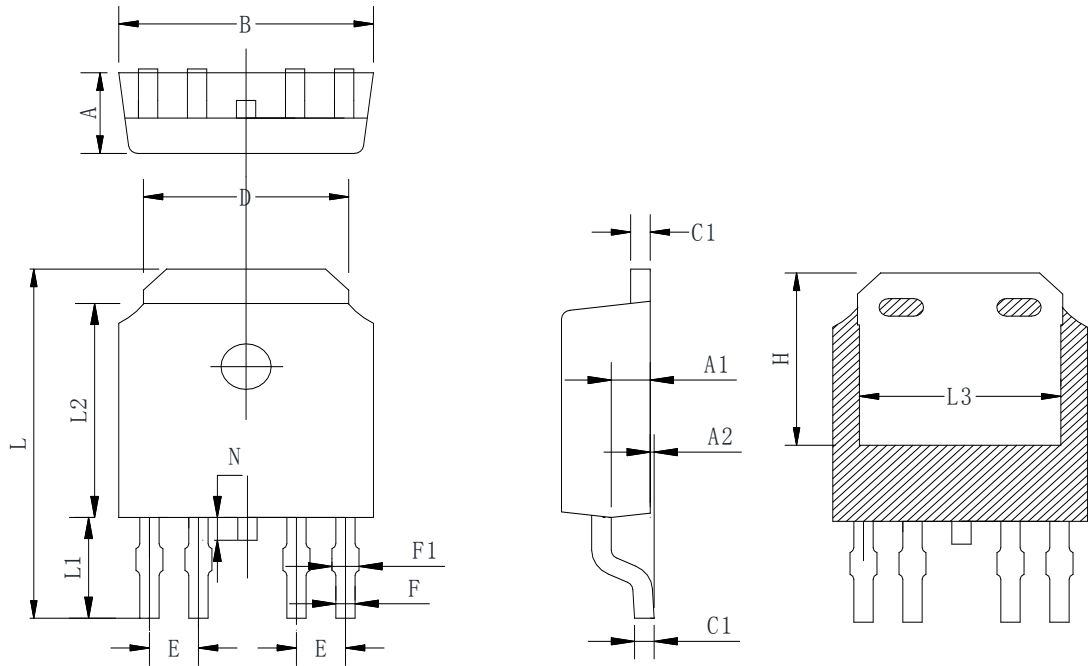


Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot

TO-252-4L PACKAGE OUTLINE



COMMON DIMENSIONS
(UNITS OF MEASURE=MILLIMETER)

SYMBOL	MIN	TYP	MAX
A	2.15	2.30	2.45
A1	0.88	1.01	1.14
A2	0.00	0.15	0.28
B	6.40	6.60	6.80
C	0.42	0.50	0.60
C1	0.42	0.50	0.60
D	5.05	5.32	5.70
E	1.27 TYP		
F1	0.40	0.60	0.80
F	0.35	0.50	0.65
H	4.60	4.90	5.40
L	9.60	10.00	10.50
L1	2.50	2.80	3.10
L2	5.80	6.10	6.40
L3	4.90	5.20	5.50
N	0.40	0.65	0.95

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Please note that some Din-Tek documentation may still make reference to RoHS Directive 2002/95/EC. We confirm that all the products identified as being compliant to Directive 2002/95/EC conform to Directive 2011/65/EU.

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